



F0810xH

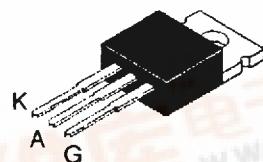
## FAST SWITCHING SCR

## FEATURES

- $I_{T(RMS)} = 8A$
- $V_{DRM} = 200V$  to  $800V$
- $t_q = 20\mu s$  max

## DESCRIPTION

The F0810xH series of SCRs uses a high performance MESA GLASS PNPN technology. These parts are intended for high frequency switching applications.



TO220  
non-insulated  
(Plastic)

## ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value	Unit
$I_{T(RMS)}$	RMS on-state current (180° conduction angle)	8	A
$I_{T(AV)}$	Average on-state current (180° conduction angle)	5.1	A
$I_{TSM}$	Non repetitive surge peak on-state current ( $T_j$ initial = 25°C )	$t_p = 8.3$ ms	88
		$t_p = 10$ ms	80
$I^2t$	$I^2t$ Value for fusing	32	$A^2s$
$dI/dt$	Critical rate of rise of on-state current $I_g = 100$ mA $dI/dt = 1$ A/ $\mu s$ .	100	$A/\mu s$
$T_{stg}$ $T_j$	Storage and operating junction temperature range	- 40, + 150 - 40, + 125	°C
$T_l$	Maximum lead temperature for soldering during 10s at 4.5mm from case	260	°C

Symbol	Parameter	Voltage				Unit
		B	D	M	N	
$V_{DRM}$ $V_{RRM}$	Repetitive peak off-state voltage $T_j = 125^\circ C$	200	400	600	800	V

## F0810xH

### THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R <sub>th(j-a)</sub>	Junction to ambient	60	°C/W
R <sub>th(j-c)</sub>	Junction to case for DC	3	°C/W

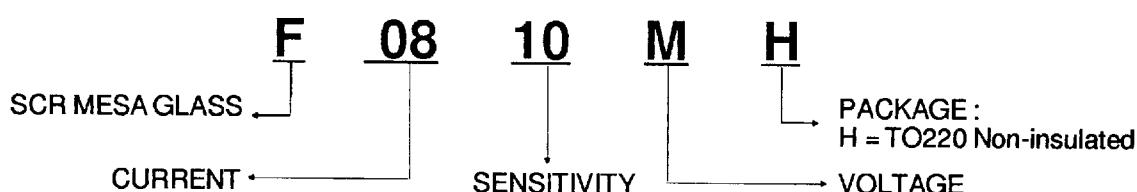
### GATE CHARACTERISTICS (maximum values)

P<sub>G (AV)</sub> = 0.5 W P<sub>GM</sub> = 2 W (t<sub>p</sub> = 20 μs) I<sub>GM</sub> = 2 A (t<sub>p</sub> = 20 μs)

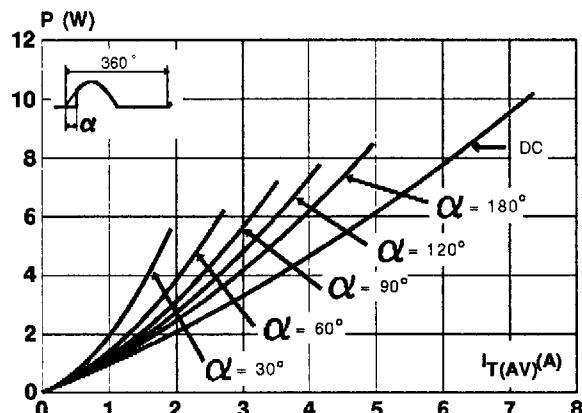
### ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions	Sensitivity		Unit
		MIN	10	
I <sub>GT</sub>	V <sub>D</sub> =12V (DC) R <sub>L</sub> =33Ω	T <sub>j</sub> = 25°C	MIN	10
			MAX	25
V <sub>GT</sub>	V <sub>D</sub> =12V (DC) R <sub>L</sub> =33Ω	T <sub>j</sub> = 25°C	MAX	1.5
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3kΩ	T <sub>j</sub> = 125°C	MIN	0.2
t <sub>GT</sub>	V <sub>D</sub> =V <sub>DRM</sub> I <sub>TM</sub> = 3 x I <sub>T(AV)</sub> dI <sub>G</sub> /dt = 0.8A/μs I <sub>G</sub> = 90mA	T <sub>j</sub> = 25°C	TYP	2
I <sub>H</sub>	I <sub>T</sub> = 250mA Gate open	T <sub>j</sub> = 25°C	MAX	75
I <sub>L</sub>	I <sub>G</sub> =1.2 I <sub>GT</sub>	T <sub>j</sub> = 25°C	MAX	150
V <sub>TM</sub>	I <sub>TM</sub> = 16A t <sub>p</sub> = 380μs	T <sub>j</sub> = 25°C	MAX	2
I <sub>DRM</sub> I <sub>RRM</sub>	V <sub>D</sub> = V <sub>DRM</sub> V <sub>R</sub> = V <sub>RRM</sub>	T <sub>j</sub> = 25°C	MAX	5
			MAX	1.5
dV/dt	V <sub>D</sub> =67%V <sub>DRM</sub> Gate open	T <sub>j</sub> = 110°C	MIN	300
t <sub>q</sub>	I <sub>TM</sub> = 3 x I <sub>T(AV)</sub> V <sub>R</sub> =35V dI/dt=25A/μs t <sub>p</sub> =100μs dV/dt=25V/μs V <sub>D</sub> = 67%V <sub>DRM</sub>	T <sub>j</sub> = 110°C	MAX	20

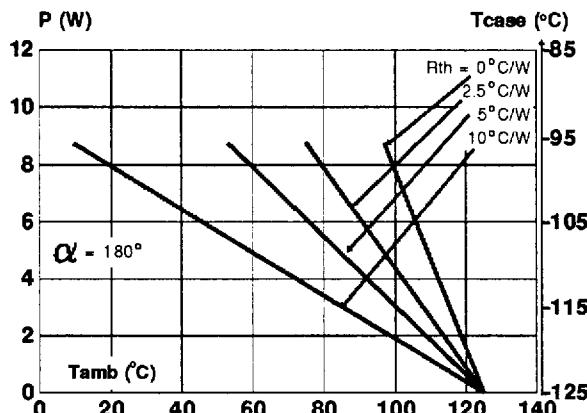
### ORDERING INFORMATION



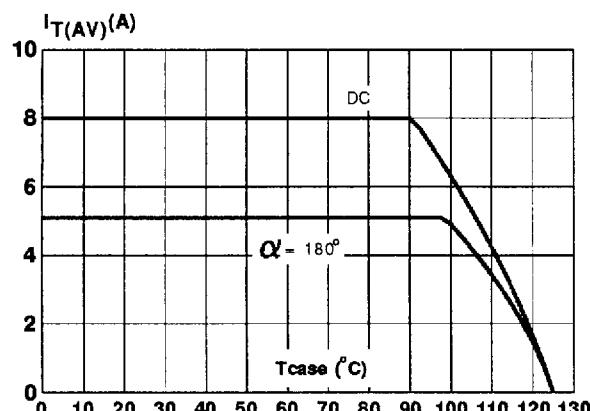
**Fig.1 :** Maximum average power dissipation versus average on-state current.



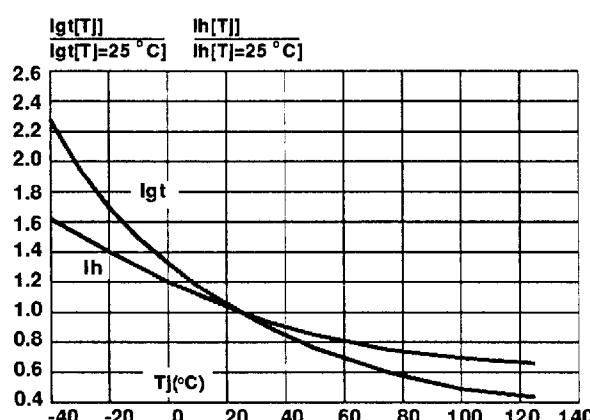
**Fig.2 :** Correlation between maximum average power dissipation and maximum allowable temperature (Tamb and Tcase) for different thermal resistances heatsink + contact.



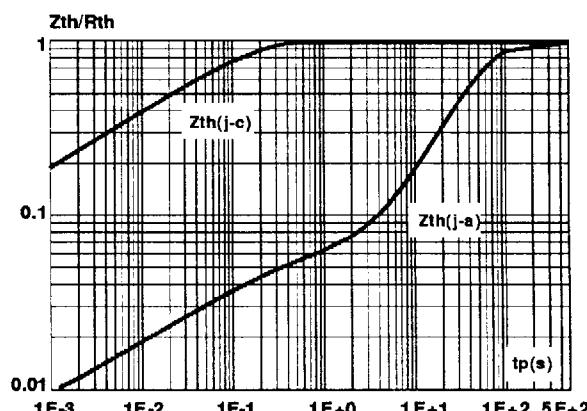
**Fig.3 :** Average on-state current versus case temperature.



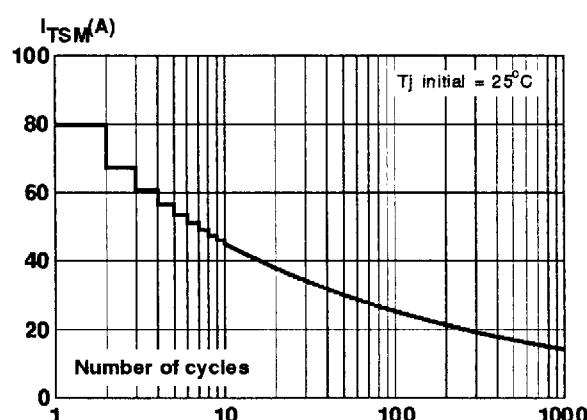
**Fig.5 :** Relative variation of gate trigger current and holding current versus junction temperature.



**Fig.4 :** Relative variation of thermal impedance versus pulse duration.



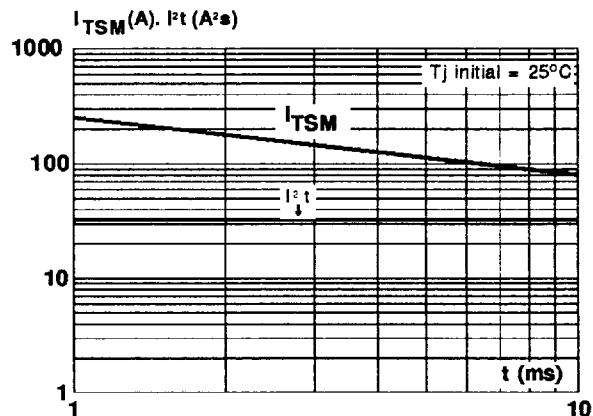
**Fig.6 :** Non repetitive surge peak on-state current versus number of cycles.



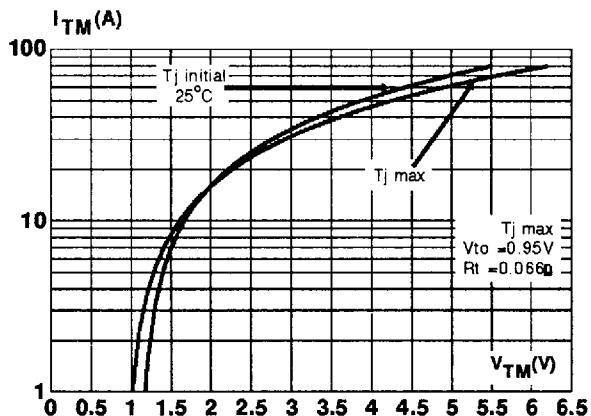
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**Fig.7 :** Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \leq 10\text{ms}$ , and corresponding value of  $I^2t$ .



**Fig.8 :** On-state characteristics (maximum values).



**PACKAGE MECHANICAL DATA**  
TO220 Non-insulated (Plastic)

REF.	DIMENSIONS					
	Millimeters			Inches		
	Typ.	Min.	Max.	Typ.	Min.	Max.
A			10.3			0.406
B	6.3	6.5	0.248	0.256		
C			9.1			0.358
D	12.7				0.500	
F			4.2			0.165
G			3.0			0.118
H	4.5	4.7		0.177	0.185	
I	3.53	3.66		0.139	0.144	
J	1.2	1.3		0.047	0.051	
L			0.9			0.035
M	2.7			0.106		
N			5.3			0.209
N1	2.54			0.100		
O	1.2	1.4		0.047	0.055	
P			1.15			0.045

Marking : type number

Weight : 1.8 g

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